

MOS FIELD EFFECT TRANSISTOR

2SK3481

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK3481 is N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

• Super low on-state resistance:

RDS(on)1 = $50 \text{ m}\Omega$ MAX. (VGS = 10 V, ID = 15 A) RDS(on)2 = $58 \text{ m}\Omega$ MAX. (VGS = 4.5 V, ID = 15 A)

- Low Ciss: Ciss = 2300 pF TYP.
- Built-in gate protection diode

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|---------------------------|
| 2SK3481 | TO-220AB |
| 2SK3481-S | TO-262 |
| 2SK3481-ZJ | TO-263 |
| 2SK3481-Z | TO-220SMD ^{Note} |

Note TO-220SMD package is produced only in Japan.

(TO-220AB)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V) | VDSS | 100 | V |
|---|-----------------|-------------|----|
| Gate to Source Voltage (Vps = 0 V) | Vgss | ±20 | V |
| Drain Current (DC) (Tc = 25°C) | ID(DC) | ±30 | Α |
| Drain Current (pulse) Note1 | ID(pulse) | ±60 | Α |
| Total Power Dissipation (Tc = 25°C) | P _{T1} | 56 | W |
| Total Power Dissipation (T _A = 25°C) | P _{T2} | 1.5 | W |
| Channel Temperature | Tch | 150 | °C |
| Storage Temperature | Tstg | -55 to +150 | °C |
| Single Avalanche Current Note2 | las | 26 | Α |
| Single Avalanche Energy Note2 | Eas | 68 | mJ |

Notes 1. PW \leq 10 μ s, Duty cycle \leq 1%

2. Starting T_{ch} = 25°C, V_{DD} = 50 V, R_G = 25 Ω , V_{GS} = 20 \rightarrow 0 V



(TO-262)



(TO-263, TO-220SMD)



THERMAL RESISTANCE

Channel to Case Thermal Resistance $R_{th(ch-C)}$ 2.23 °C/W Channel to Ambient Thermal Resistance $R_{th(ch-A)}$ 83.3 °C/W

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

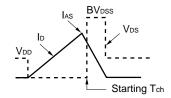


ELECTRICAL CHARACTERISTICS (TA = 25°C)

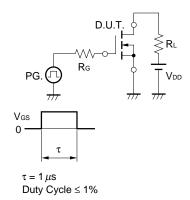
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|--|------|------|------|------|
| Zero Gate Voltage Drain Current | IDSS | V _{DS} = 100 V, V _{GS} = 0 V | | | 10 | μΑ |
| Gate Leakage Current | Igss | Vgs = ±20 V, Vps = 0 V | | | ±10 | μΑ |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1 mA | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | yfs | V _{DS} = 10 V, I _D = 15 A | 9 | 18 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | V _{GS} = 10 V, I _D = 15 A | | 40 | 50 | mΩ |
| | RDS(on)2 | V _{GS} = 4.5 V, I _D = 15 A | | 44 | 58 | mΩ |
| Input Capacitance | Ciss | V _{DS} = 10 V | | 2300 | | pF |
| Output Capacitance | Coss | V _G S = 0 V | | 230 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1 MHz | | 120 | | pF |
| Turn-on Delay Time | t _{d(on)} | V _{DD} = 50 V, I _D = 15 A | | 13 | | ns |
| Rise Time | tr | V _{GS} = 10 V | | 10 | | ns |
| Turn-off Delay Time | t _{d(off)} | $R_G = 0 \Omega$ | | 53 | | ns |
| Fall Time | t f | | | 5.0 | | ns |
| Total Gate Charge | QG | VDD = 80 V | | 48 | | nC |
| Gate to Source Charge | Qgs | V _{GS} = 10 V | | 7.0 | | nC |
| Gate to Drain Charge | QGD | ID = 30 A | | 12 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | IF = 30 A, VGS = 0 V | | 1.0 | | V |
| Reverse Recovery Time | trr | IF = 30 A, VGS = 0 V | | 70 | | ns |
| Reverse Recovery Charge | Qrr | di/dt = 100 A/ μs | | 160 | | nC |

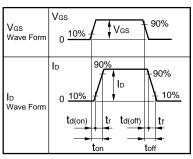
TEST CIRCUIT 1 AVALANCHE CAPABILITY

$\begin{array}{c|c} \text{D.U.T.} \\ \text{RG} = 25 \ \Omega \\ \text{PG.} \\ \hline \\ \text{VGS} = 20 \rightarrow 0 \ V \\ \end{array} \begin{array}{c} \text{D.U.T.} \\ \\ \text{VDD} \\ \end{array}$



TEST CIRCUIT 2 SWITCHING TIME



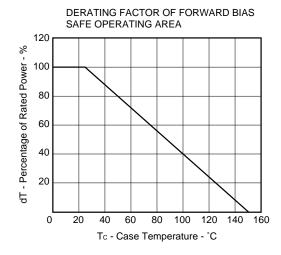


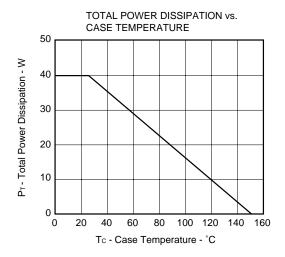
TEST CIRCUIT 3 GATE CHARGE

2

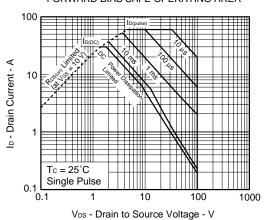


TYPICAL CHARACTERISTICS (TA = 25°C)

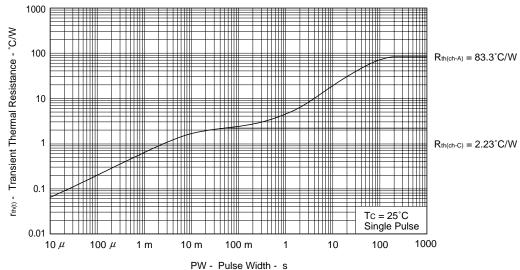




FORWARD BIAS SAFE OPERATING AREA

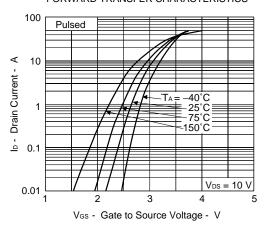


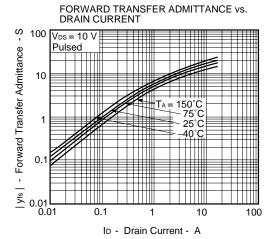




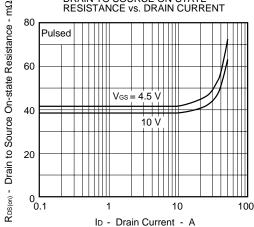
Data Sheet D15063EJ1V0DS

FORWARD TRANSFER CHARACTERISTICS

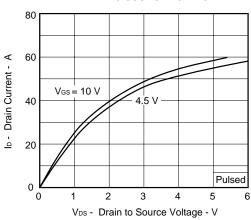




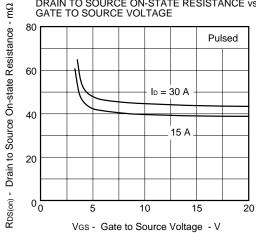
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

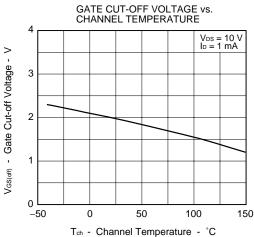


DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE

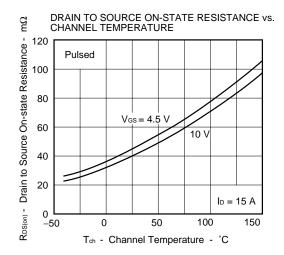


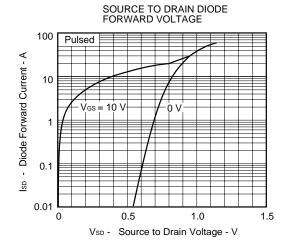
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

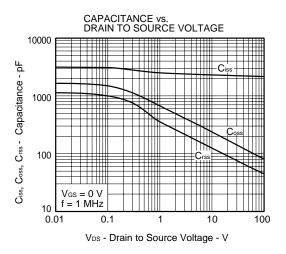


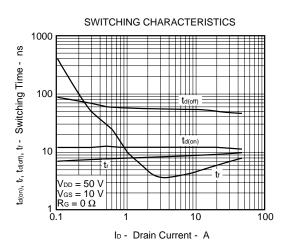


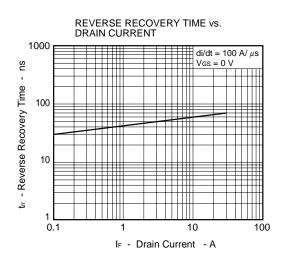


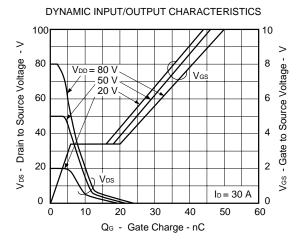


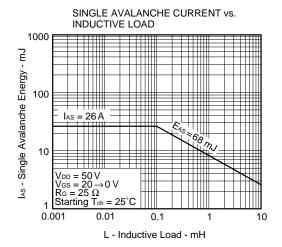


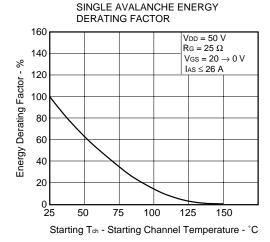








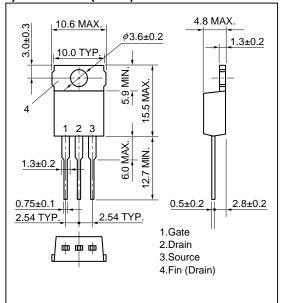




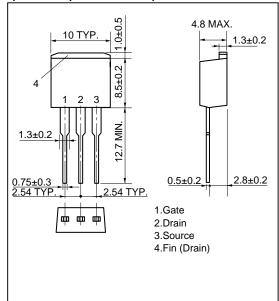


PACKAGE DRAWINGS (Unit: mm)

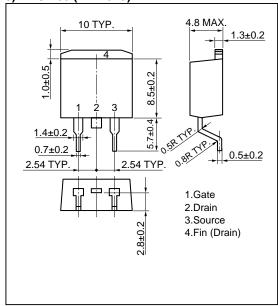
1) TO-220AB (MP-25)



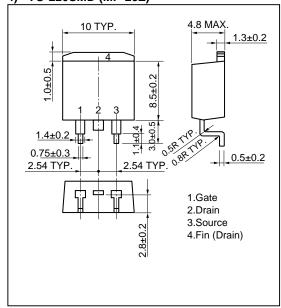
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)

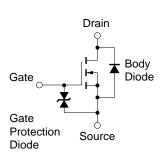


4) TO-220SMD (MP-25Z)^{Note}



Note This package is produced only in Japan.

EQUIVALENT CIRCUIT



Remark

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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